

XploRA Series

Simply Better Raman



Chemical Analysis & Imaging
for Research & Industry

Why Raman ?

Advantages

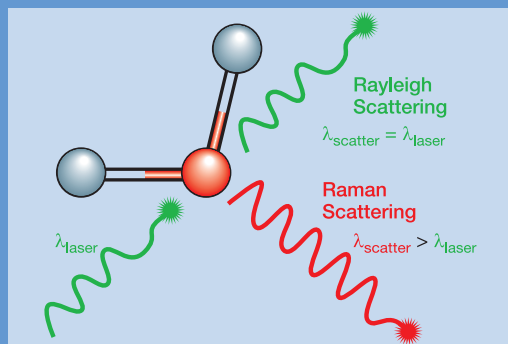
- Non-destructive
- Non-contact/*In-situ* sampling
- Reduced sample preparation
- Water/aqueous phase sampling
- Organic/inorganic molecules
- Amorphous/crystalline

Raman is an ideal technique for research and industry offering high quality data, reliability, versatility and improved value for money over other analytical techniques. Benefits not only include the range of samples that are suitable for analysis, but also the information content that is provided.

- Chemical identification
- Quality testing
- Process/product troubleshooting
- Contamination and inclusion analysis
- Raw materials inspection

Principle

Interaction of laser light with a sample results in a Raman spectrum - a detailed chemical fingerprint. Combined with an optical microscope, this provides sample identification and chemical imaging on a microscopic scale.



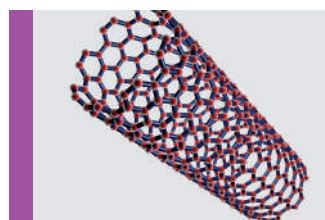
The sensitivity, spectroscopic and imaging performance of the XploRA product line

enables the broadest range of sample analysis.

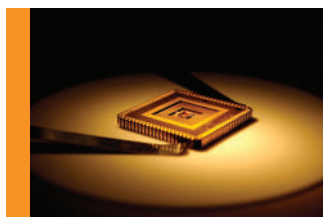
Pharmaceuticals



Nano-materials



Semiconductors



Polymers



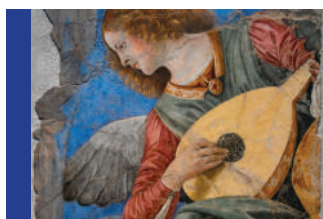
Geology



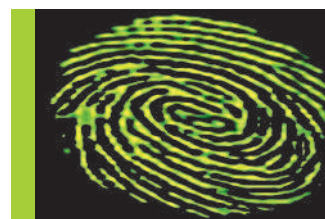
Chemicals



Art and Museum



Forensics



XploRA Series



XploRA PLUS: Research

➤ Raman imaging has never been so fast!

The XploRA PLUS incorporates unique and powerful functions in a reliable, high performance system, ideally suited to the research and analytical lab.

It is **fully confocal**, not compromising image quality, spatial or depth resolution. The **SWIFT™ Fast Raman images** are the fastest fully confocal Raman images available, typically 10x faster than conventional Raman imaging.

The simplicity and power of the XploRA PLUS is unmatched with an enhanced range of options such as multiple laser wavelengths, EMCCD detection, Raman polarisation and even AFM Raman TERS combination.

It is the best platform for multi-sample and multi-user environments.

- Fastest confocal imaging
- Automated laser wavelength switching with just a single mouse click
- Large range of options and accessories



XploRA ONE: Analytical

➤ Raman analysis has never been so easy!

The XploRA ONE offers new capabilities to the industrial and analytical user, providing the highest performance Raman, in a **cost effective and robust instrument package**.

It is ideal for routine analytical, research and quality testing applications.

- OneClick operation
- Auto-calibration in OneCheck
- Regulatory compliance: 21 CFR11

XploRA INV: Life Science

➤ Hybrid biological imaging and analysis made easy!

The XploRA INV Raman microscope is the only **truly analytical inverted Raman microscope**. Configured for high sensitivity bio-Raman spectroscopy. It offers TRUE confocal performance with low maintenance and dedicated software for ease of operation.

The uniquely integrated system design ensures stability, optimizing the imaging workflow. The integrated inverted microscope enables multi-modal analysis, such as **fluorescence, Raman, laser tweezing and even TERS analysis** to be conducted upon the same instrument and at the same sample position.

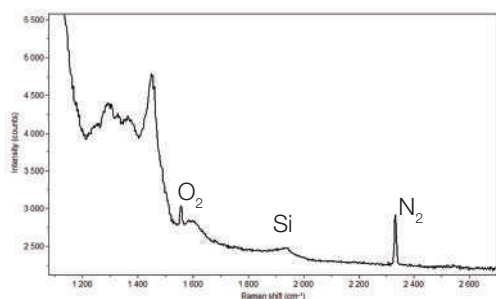
- Inverted life-science microscope
- Fast and simple sample imaging
- Multi-modal analysis



The XploRA

Innovation provides improved productivity and extended reliability.

- Superior CCD and EMCCD for Class leading S:N
- Easier and faster analysis
- Requiring far less laser power on the sample, preserving sample integrity
- Ability to detect thin films, small particles, and dilute solutions



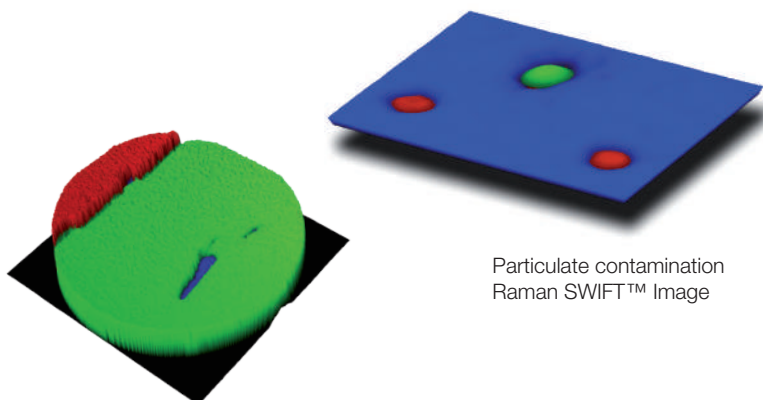
Silicon (Si) 4th order sensitivity

- Suitable for all laser wavelengths
- Scalable to large area and micron scale imaging for maximum image detail
- Means faster and more reliable Raman imaging at the click of a button
- Fully confocal for improved image detail

Improved Detection and Sensitivity

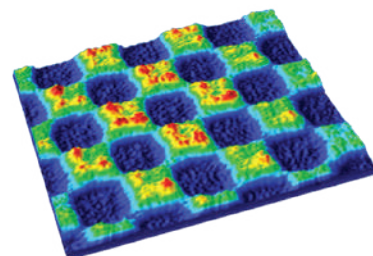
Raman Imaging just got *Faster & Easier* with SWIFT™ and SWIFTXS

Combined with an EMCCD, **SWIFTXS** pushes the speed of confocal Raman imaging to the next level. Accelerate your chemical imaging and generate high definition Raman images in minute timescale. **Supercharge your Raman Imaging!**



Particulate contamination
Raman SWIFT™ Image

Fast SWIFT™ image of semiconductor defect, obtained in less than 2 minutes



40 200 spectra acquired in less than 50 seconds
Structured semiconductor device, Raman SWIFTXS image

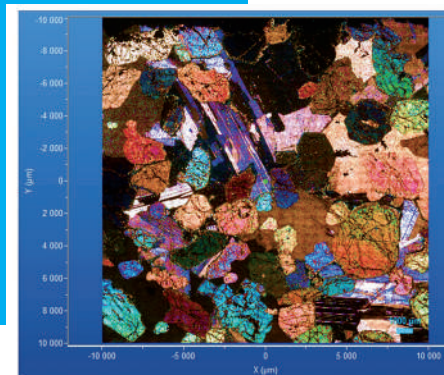


At a Glance

Technical design offers automation and class leading ease of operation.



Full Optical Microscopy To See Your Sample

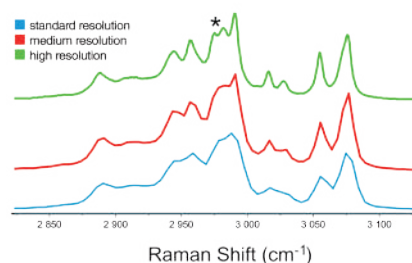


Extended polarized light microscope image

- All modes of microscopy, transmission and reflection illumination
- Options for DIC, phase, epifluorescence, dark field and polarized light microscopy
- Automated Extended Video Montage
- Range of options such as Autofocus, and ParticleFinder (auto-location) will never limit the scope of the optical microscopy

Maximum Detail, Resolution and Range

- Optimized range and resolution in one-shot for all lasers
- Full range optics enables detail over the complete Raman spectrum
- The high resolution ability of the XploRA PLUS and INV, provide the highest spectroscopic detail while optimizing the Raman sensitivity



Raman spectra of pharmaceuticals and organics can often show subtle information in the 2800-3400 cm^{-1} region

Raman Data in Seconds: For Industrial Quality Control, Research and Analytical Testing

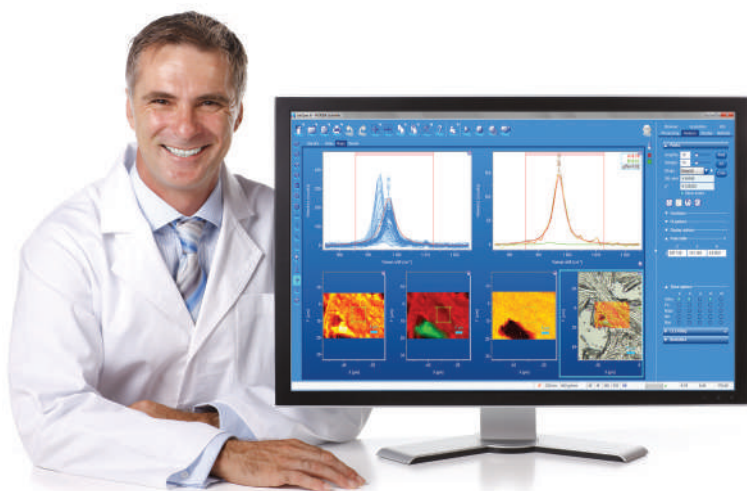
The XploRA Series offers full spectral analysis in OneClick Operation.



Simple operation, speed, low maintenance and push button results enables you to optimize productivity and efficiency.

The XploRA Series is driven by [LabSpec's](#) intuitive user interface enabling logical workflow through an experiment.

- HORIBA OneClick Raman operation
- Autocalibration
- Enhanced multi-page analysis reports
- Augmented help and troubleshooting
- Sample methods for routine repetition
- User login accounts for system security
- 3D volume and topography imaging
- Enhanced on-the-fly image generation
- Support of multi-screen PC environments
- Extended microscope image correction
- Extensive spectral database/libraries
- Easier chemometric processing
- ParticleFinder for automated particle location



Easily Expand your Analytical Technique

Benefits of XploRA Raman Microscopy in Research and Industrial Analysis		Compared to
<ul style="list-style-type: none"> • No sample preparation • Full optical microscope • Water based samples • Sub-micron scale analysis 	<ul style="list-style-type: none"> • Non-contact analysis • Multi-layer analysis • Inorganics • Polymer backbone characterization 	FTIR
<ul style="list-style-type: none"> • Non-destructive analysis • No sample preparation • Solids/surface analysis 	<ul style="list-style-type: none"> • Molecular/crystal structure • Fast analysis times typically > 2 seconds • Low maintenance 	Mass Spectrometry
<ul style="list-style-type: none"> • Crystalline and amorphous materials • Single particle analysis 	<ul style="list-style-type: none"> • In-situ environmental stages (heating/cooling/relative humidity) • Small benchfootprint 	XRD
<ul style="list-style-type: none"> • Chemical information and chemical images 		Optical Microscopy
<ul style="list-style-type: none"> • No sample preparation • Environmental conditions: no vacuum, heating/cooling/relative humidity controlled stages • Fast analysis times and sample throughput 	<ul style="list-style-type: none"> • Fast start-up and ready to analyze time in less than 10 minutes from off • Multi-layer samples • Small bench footprint 	SEM

Simplified Workflow

With  **LabSpec 6**
Spectroscopy suite



Auto-Calibration
OneCheck

Input Sample
No preparation

Focus
Microscope

Easy
Navigation

Raman
Acquisition

Obtain Result
Match to Library

Report Result

Simplified Calibration and Validation

The patented calibration objective tool uses a certified reference material and ASTM method for system validation and ensures fast, easy calibration and validation of the instrument.



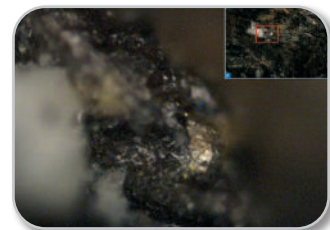
OneCheck and the system is ready to run.

Impressively fast start-up time, less than 10 minutes from cold, removes the need for any lengthy start-up procedures, adjustment or the need for the system to be continually powered on. Ideal for laboratory efficiency, running costs and the environment!

EasyNav™



With the groundbreaking EasyNav™ package, it is fast and easy to navigate in-focus, in real-time, to identify the region of interest and obtain sharp, clear Raman chemical images, thanks to three new revolutionary applications: NavMap™, NavSharp™ and ViewSharp™.



NavMap™ View

OneClick Raman Acquisition



OneClick Raman acquisition optimizes acquisition parameters and signal processing in OneClick, including baseline corrections, fluorescence rejection and noise reduction.

XploRA Series Specifications

	Industrial	Research	Bio/Life science	Nano Raman
	XploRA™ One	XploRA™ PLUS	XploRA™ INV	XploRA™ AFM Raman
Faster Raman SWIFT™ Imaging / SWIFTXS (with EMCCD)	YES with XY stage	YES with XY stage	YES with XY stage Optional DuoScan™ imaging	YES Optional XY stage & DuoScan™ depending upon version
Confocal Imaging	1 µm XY	0.5 µm XY	0.5 µm XY	0.5 µm XY 10 nm* with TERS
Routine operation Automation	OneClick Auto/Raw	OneClick Auto	Methods and scripts	Integrated AFM Raman software
Full Microscope	Upright	Upright	Inverted	Upright and/or inverted
Resolution	Standard	Standard + High	Standard + High	Standard + High
Multi-laser Options	Single laser 532 and 785 nm	532, 638, 785 nm others on request	532, 638, 785 nm others on request	532, 638, 785 nm others on request

* Requires HORIBA TERS tips

XploRA Nano

- AFM Raman module
- XploRA PLUS and INV versions
- TERS Ready: 10 nm resolution*
- Multi-sampling geometry: upright-inverted-side axis
- SWIFT™ Nano-Raman images
- High performance AFM functionality
- Integrated control and construction
- Stability and reliability

The XploRA PLUS and INV can add the NanoRaman (TERS) extension to probe nanometer structures and single molecules in a single compact, high performance system.



$\lambda = (400 \text{ nm} - 800 \text{ nm})$ $P \leq 150 \text{ mW}$
VISIBLE AND/OR INVISIBLE LASER RADIATION
AVOID EXPOSURE TO BEAM
CLASS 3B LASER PRODUCT



Find out more at www.horiba.com/xplora

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Scientific

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